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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Complete if Known	
Application Number	Unknown
Filing Date	Even Date Herewith
First Named Inventor	Marr, Kenneth
Group Art Unit	Unknown
Examiner Name	Unknown

Sheet 1 of 3

Attorney Docket No: 303.674US2

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	First Named Inventor	Marr, Kenneth
	Group Art Unit	Unknown
	Examiner Name	Unknown
Sheet 2 of 3	Attorney Docket No: 303.674US2	

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	Filing Date	Even Date Herewith
	First Named Inventor	Marr, Kenneth
	Group Art Unit	Unknown
	Examiner Name	Unknown
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Substitute Disclosure Statement Form (PTO-1449)

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